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Bib Data Sheet

CONFIRMATION NO. 5574

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|-----------------------------|-----------------------------------|--------------|------------------------|-------------------------------------|
| SERIAL NUMBER 10/659,626 | FILING DATE 09/10/2003 RULE | CLASS 356 | GROUP ART UNIT 2877 | ATTORNEY DOCKET NO. TWI-23010 |
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APPLICANTS

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** CONTINUING DATA *****

This appln claims benefit of 60/413,229 09/23/2002
and claims benefit of 60/413,094 09/24/2002

yes fl 2/17/06

** FOREIGN APPLICATIONS *****

none fl 2/17/06

IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** SMALL ENTITY **

** 12/02/2003

| Foreign Priority claimed | <input type="checkbox"/> yes <input checked="" type="checkbox"/> no | STATE OR COUNTRY | SHEETS DRAWING | TOTAL CLAIMS | INDEPENDENT CLAIMS |
|---------------------------------|---|------------------------|-------------------|-----------------|-----------------------|
| 35 USC 119 (a-d) conditions met | <input type="checkbox"/> yes <input checked="" type="checkbox"/> no | Met after Allowance | | | |
| Verified and Acknowledged | Examiner's Signature | Initials | CA | 4 | 10 |

ADDRESS

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TITLE

Modulated reflectance measurement system using UV probe

| | | |
|------------|---|---|
| FILING FEE | FEES: Authority has been given in Paper | <input type="checkbox"/> All Fees |
| | | <input type="checkbox"/> 1.16 Fees (Filing) |
| | | <input type="checkbox"/> 1.17 Fees (Processing Ext. of |